Notice of References Cited Application/Control No. O9/914.440 Examiner Nikolas J. Uhlir Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name _	Classification
	Α	US-5753740	05-1998	Odawa et al.	524/414
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